

Search Notes

Application/Control No.

09/537,367

Examiner

CHAN S. PARK

Applicant(s)/Patent under
Reexamination

SAWANO, TAKASHI

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see the search history)	5/4/2005	CP